

ecoSWITCH™

Advanced Load Management

Controlled Load Switch with Low R_{ON}

NCP45541

The NCP45541 load switch provides a component and area-reducing solution for efficient power domain switching with inrush current limit via soft-start. In addition to integrated control functionality with ultra low on-resistance, this device offers system monitoring via power good signaling. This cost effective solution is ideal for power management and hot-swap applications requiring low power consumption in a small footprint.

Features

- Advanced Controller with Charge Pump
- Integrated N-Channel MOSFET with Low R_{ON}
- Input Voltage Range 0.5 V to 13.5 V
- Soft-Start via Controlled Slew Rate
- Adjustable Slew Rate Control
- Power Good Signal
- Extremely Low Standby Current
- Load Bleed (Quick Discharge)
- This is a Pb-Free Device

Typical Applications

- Portable Electronics and Systems
- Notebook and Tablet Computers
- Telecom, Networking, Medical, and Industrial Equipment
- Set-Top Boxes, Servers, and Gateways
- Hot-Swap Devices and Peripheral Ports

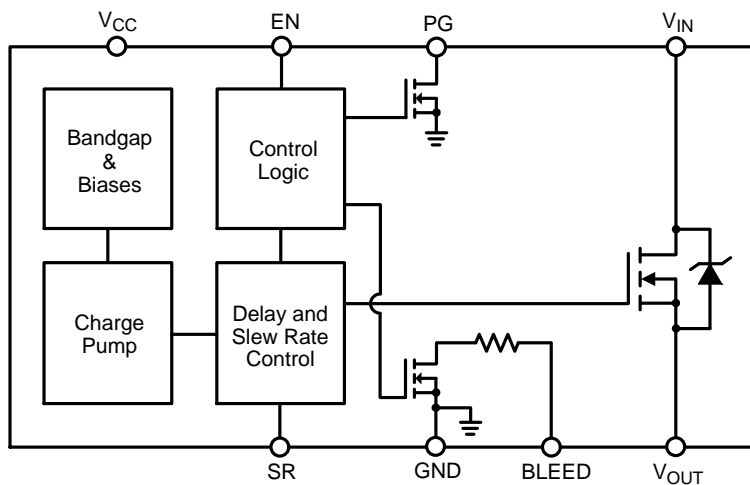


Figure 1. Block Diagram

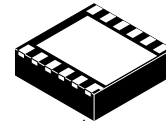


ON Semiconductor®

www.onsemi.com

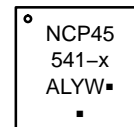
R_{ON} TYP	V_{CC}	V_{IN}	$I_{MAX_DC}^*$
7.7 mΩ	3.3 V	1.8 V	14 A
8.0 mΩ	3.3 V	5.0 V	
9.2 mΩ	3.3 V	12 V	

* I_{MAX_DC} is defined as the maximum steady state current the load switch can pass at room ambient temperature without entering thermal lockout.



DFN12, 3x3
CASE 506CD

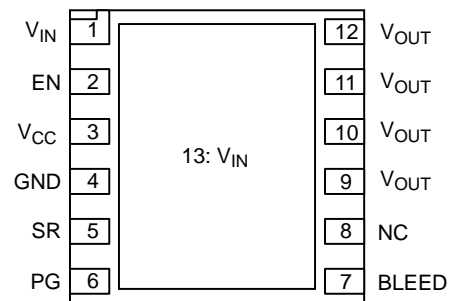
MARKING DIAGRAM



x = H for NCP45541-H
 = L for NCP45541-L
 A = Assembly Location
 L = Wafer Lot
 Y = Year
 W = Work Week
 ■ = Pb-Free Package

(Note: Microdot may be in either location)

PIN CONFIGURATION



(Top View)

ORDERING INFORMATION

See detailed ordering and shipping information on page 12 of this data sheet.

NCP45541

Table 1. PIN DESCRIPTION

Pin	Name	Function
1, 13	V _{IN}	Drain of MOSFET (0.5 V – 13.5 V), Pin 1 must be connected to Pin 13
2	EN	NCP45541–H – Active–high digital input used to turn on the MOSFET, pin has an internal pull down resistor to GND
		NCP45541–L – Active–low digital input used to turn on the MOSFET, pin has an internal pull up resistor to V _{CC}
3	V _{CC}	Supply voltage to controller (3.0 V – 5.5 V)
4	GND	Controller ground
5	SR	Slew rate adjustment; float if not used
6	PG	Active–high, open–drain output that indicates when the gate of the MOSFET is fully driven, external pull up resistor ≥ 1 kΩ to an external voltage source required; tie to GND if not used.
7	BLEED	Load bleed connection, must be tied to V _{OUT} either directly or through a resistor ≤ 100 MΩ
8	NC	No connect, internally floating but pin may be tied to V _{OUT}
9–12	V _{OUT}	Source of MOSFET connected to load

Table 2. ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Supply Voltage Range	V _{CC}	–0.3 to 6	V
Input Voltage Range	V _{IN}	–0.3 to 18	V
Output Voltage Range	V _{OUT}	–0.3 to 18	V
EN Digital Input Range	V _{EN}	–0.3 to (V _{CC} + 0.3)	V
PG Output Voltage Range (Note 1)	V _{PG}	–0.3 to 6	V
Thermal Resistance, Junction–to–Ambient, Steady State (Note 2)	R _{θJA}	30.9	°C/W
Thermal Resistance, Junction–to–Ambient, Steady State (Note 3)	R _{θJA}	51.3	°C/W
Thermal Resistance, Junction–to–Case (V _{IN} Paddle)	R _{θJC}	3.5	°C/W
Continuous MOSFET Current @ T _A = 25°C (Note 2)	I _{MAX}	14	A
Continuous MOSFET Current @ T _A = 25°C (Note 3)	I _{MAX}	15.5	A
Transient MOSFET Current (for up to 500 μs)	I _{MAX_TRANS}	24	A
Total Power Dissipation @ T _A = 25°C (Note 2) Derate above T _A = 25°C	P _D	3.24 32.4	W mW/°C
Total Power Dissipation @ T _A = 25°C (Note 3) Derate above T _A = 25°C	P _D	1.95 19.5	W mW/°C
Storage Temperature Range	T _{STG}	–40 to 150	°C
Lead Temperature, Soldering (10 sec.)	T _{SLD}	260	°C
ESD Capability, Human Body Model (Notes 4 and 5)	ESD _{HBM}	3.0	kV
ESD Capability, Charged Device Model (Note 4)	ESD _{CDM}	1.0	kV
Latch–up Current Immunity (Notes 4 and 5)	LU	100	mA

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- PG is an open–drain output that requires an external pull up resistor ≥ 1 kΩ to an external voltage source.
- Surface–mounted on FR4 board using 1 sq–in pad, 1 oz Cu.
- Surface–mounted on FR4 board using the minimum recommended pad size, 1 oz Cu.
- Tested by the following methods @ T_A = 25°C:
 ESD Human Body Model tested per JESD22–A114
 ESD Charged Device Model per ESD STM5.3.1
 Latch–up Current tested per JESD78
- Rating is for all pins except for V_{IN} and V_{OUT} which are tied to the internal MOSFET's Drain and Source. Typical MOSFET ESD performance for V_{IN} and V_{OUT} should be expected and these devices should be treated as ESD sensitive.

NCP45541

Table 3. RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Supply Voltage	V_{CC}	3	5.5	V
Input Voltage	V_{IN}	0.5	13.5	V
Ground	GND		0	V
Ambient Temperature	T_A	-40	85	°C
Junction Temperature	T_J	-40	125	°C
OFF to ON Transition Energy Dissipation Limit (See application section)	E_{TRANS}	0	130	mJ

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Table 4. ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Conditions (Note 6)	Symbol	Min	Typ	Max	Unit
MOSFET						
On-Resistance	$V_{CC} = 3.3\text{ V}; V_{IN} = 1.8\text{ V}$	R_{ON}		7.7	8.9	m Ω
	$V_{CC} = 3.3\text{ V}; V_{IN} = 5\text{ V}$			8.0	9.3	
	$V_{CC} = 3.3\text{ V}; V_{IN} = 12\text{ V}$			9.2	12.1	
Leakage Current (Note 7)	$V_{EN} = 0\text{ V}; V_{IN} = 13.5\text{ V}$	I_{LEAK}		0.1	1.0	μA
CONTROLLER						
Supply Standby Current (Note 8)	$V_{EN} = 0\text{ V}; V_{CC} = 3\text{ V}$	I_{STBY}		0.65	2.0	μA
	$V_{EN} = 0\text{ V}; V_{CC} = 5.5\text{ V}$			3.2	4.5	
Supply Dynamic Current (Note 9)	$V_{EN} = V_{CC} = 3\text{ V}; V_{IN} = 12\text{ V}$	I_{DYN}		180	300	μA
	$V_{EN} = V_{CC} = 5.5\text{ V}; V_{IN} = 1.8\text{ V}$			475	680	
Bleed Resistance	$V_{EN} = 0\text{ V}; V_{CC} = 3\text{ V}$	R_{BLEED}	86	115	144	Ω
	$V_{EN} = 0\text{ V}; V_{CC} = 5.5\text{ V}$		72	97	121	
EN Input High Voltage	$V_{CC} = 3\text{ V} - 5.5\text{ V}$	V_{IH}	2.0			V
EN Input Low Voltage	$V_{CC} = 3\text{ V} - 5.5\text{ V}$	V_{IL}			0.8	V
EN Input Leakage Current	NCP45541-H; $V_{EN} = 0\text{ V}$	I_{IL}		90	500	nA
	NCP45541-L; $V_{EN} = V_{CC}$	I_{IH}		90	500	
EN Pull Down Resistance	NCP45541-H	R_{PD}	76	100	124	k Ω
EN Pull Up Resistance	NCP45541-L	R_{PU}	76	100	124	k Ω
PG Output Low Voltage (Note 10)	$V_{CC} = 3\text{ V}; I_{SINK} = 5\text{ mA}$	V_{OL}			0.2	V
PG Output Leakage Current (Note 11)	$V_{CC} = 3\text{ V}; V_{TERM} = 3.3\text{ V}$	I_{OH}		5.0	100	nA
Slew Rate Control Constant (Note 12)	$V_{CC} = 3\text{ V}$	K_{SR}	26	33	40	μA

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. V_{EN} shown only for NCP45541-H, (EN Active-High) unless otherwise specified.

7. Average current from V_{IN} to V_{OUT} with MOSFET turned off.

8. Average current from V_{CC} to GND with MOSFET turned off.

9. Average current from V_{CC} to GND after charge up time of MOSFET.

10. PG is an open-drain output that is pulled low when the MOSFET is disabled.

11. PG is an open-drain output that is not driven when the gate of the MOSFET is fully charged, requires an external pull up resistor $\geq 1\text{ k}\Omega$ to an external voltage source, V_{TERM} .

12. See Applications Information section for details on how to adjust the slew rate.

NCP45541

Table 5. SWITCHING CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified) (Notes 13 and 14)

Parameter	Conditions	Symbol	Min	Typ	Max	Unit
Output Slew Rate	$V_{CC} = 3.3\text{ V}; V_{IN} = 1.8\text{ V}$	SR		11.8		kV/s
	$V_{CC} = 5.0\text{ V}; V_{IN} = 1.8\text{ V}$			12.0		
	$V_{CC} = 3.3\text{ V}; V_{IN} = 12\text{ V}$			13.3		
	$V_{CC} = 5.0\text{ V}; V_{IN} = 12\text{ V}$			13.5		
Output Turn-on Delay	$V_{CC} = 3.3\text{ V}; V_{IN} = 1.8\text{ V}$	T_{ON}		200		μs
	$V_{CC} = 5.0\text{ V}; V_{IN} = 1.8\text{ V}$			170		
	$V_{CC} = 3.3\text{ V}; V_{IN} = 12\text{ V}$			260		
	$V_{CC} = 5.0\text{ V}; V_{IN} = 12\text{ V}$			250		
Output Turn-off Delay	$V_{CC} = 3.3\text{ V}; V_{IN} = 1.8\text{ V}$	T_{OFF}		2.0		μs
	$V_{CC} = 5.0\text{ V}; V_{IN} = 1.8\text{ V}$			1.6		
	$V_{CC} = 3.3\text{ V}; V_{IN} = 12\text{ V}$			0.7		
	$V_{CC} = 5.0\text{ V}; V_{IN} = 12\text{ V}$			0.4		
Power Good Turn-on Time	$V_{CC} = 3.3\text{ V}; V_{IN} = 1.8\text{ V}$	$T_{PG,ON}$		1.02		ms
	$V_{CC} = 5.0\text{ V}; V_{IN} = 1.8\text{ V}$			0.95		
	$V_{CC} = 3.3\text{ V}; V_{IN} = 12\text{ V}$			1.52		
	$V_{CC} = 5.0\text{ V}; V_{IN} = 12\text{ V}$			1.23		
Power Good Turn-off Time	$V_{CC} = 3.3\text{ V}; V_{IN} = 1.8\text{ V}$	$T_{PG,OFF}$		20		ns
	$V_{CC} = 5.0\text{ V}; V_{IN} = 1.8\text{ V}$			14		
	$V_{CC} = 3.3\text{ V}; V_{IN} = 12\text{ V}$			20		
	$V_{CC} = 5.0\text{ V}; V_{IN} = 12\text{ V}$			14		

13. See below figure for Test Circuit and Timing Diagram.
 14. Tested with the following conditions: $V_{TERM} = V_{CC}$; $R_{PG} = 100\text{ k}\Omega$; $R_L = 10\text{ }\Omega$; $C_L = 0.1\text{ }\mu\text{F}$.

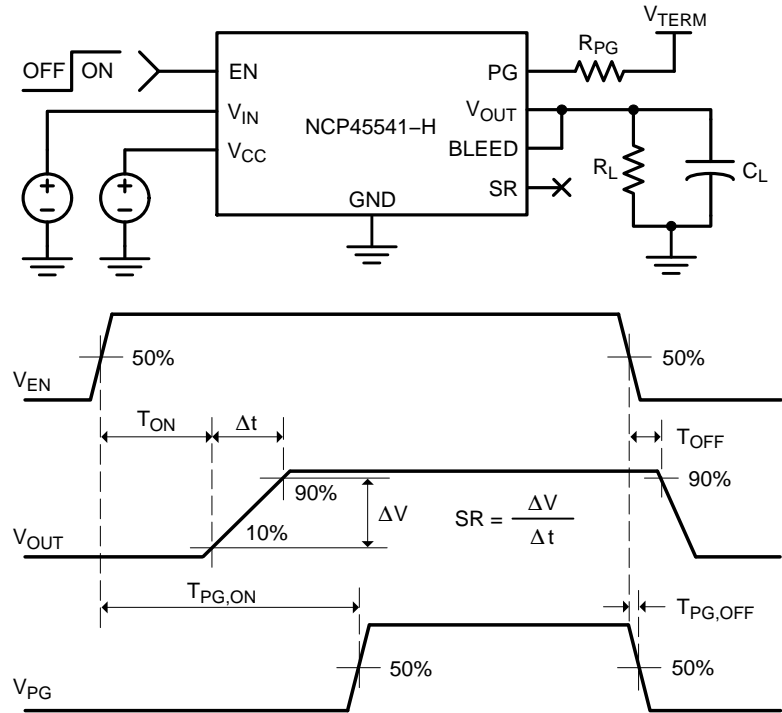


Figure 2. Switching Characteristics Test Circuit and Timing Diagrams

TYPICAL CHARACTERISTICS

($T_J = 25^\circ\text{C}$ unless otherwise specified)

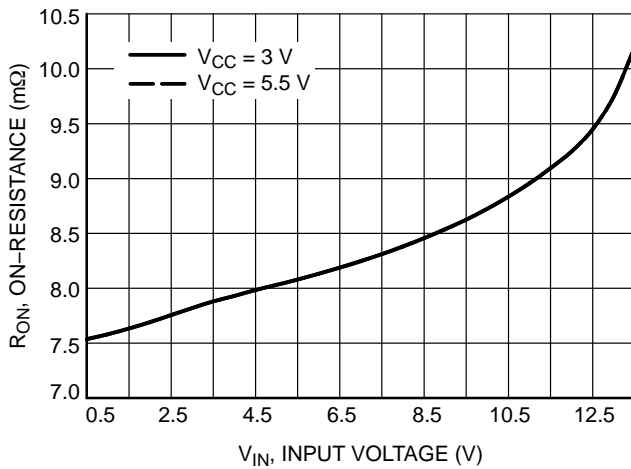


Figure 3. On-Resistance vs. Input Voltage

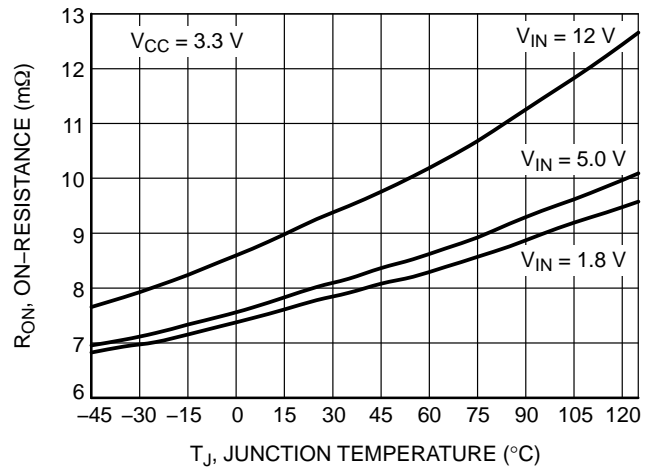


Figure 4. On-Resistance vs. Temperature

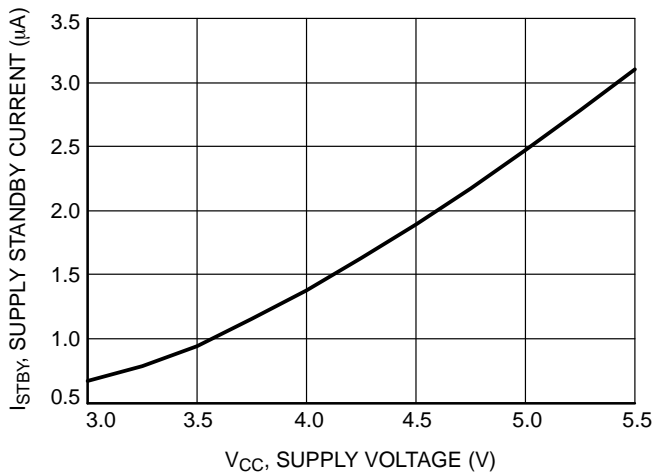


Figure 5. Supply Standby Current vs. Supply Voltage

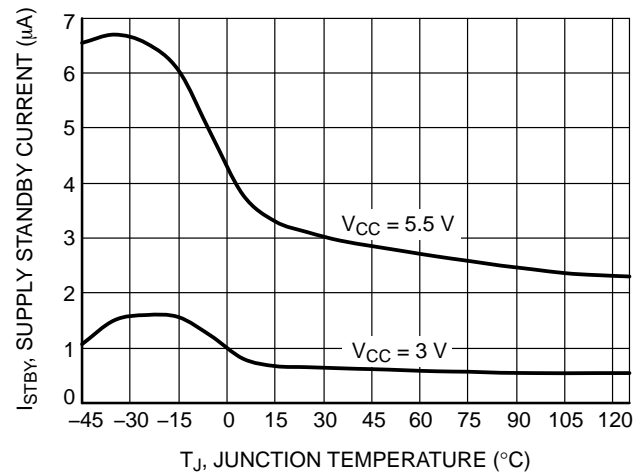


Figure 6. Supply Standby Current vs. Temperature

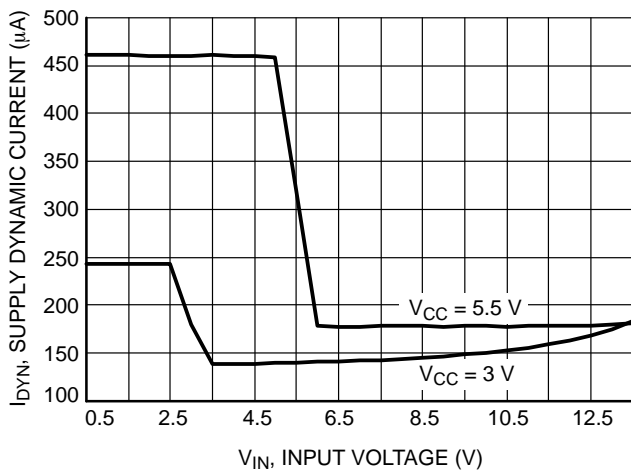


Figure 7. Supply Dynamic Current vs. Input Voltage

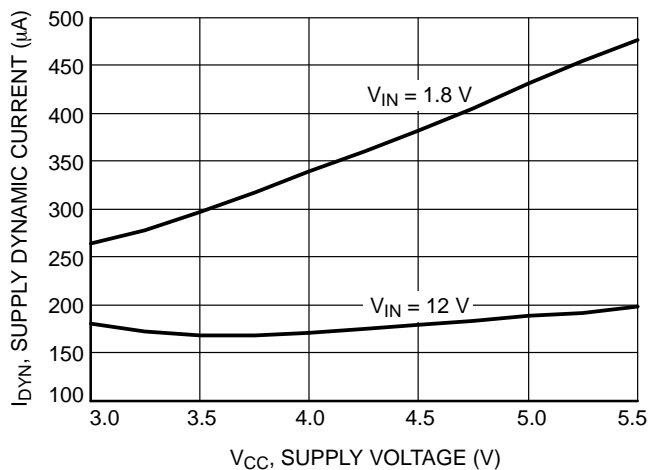


Figure 8. Supply Dynamic Current vs. Supply Voltage

TYPICAL CHARACTERISTICS

($T_J = 25^\circ\text{C}$ unless otherwise specified)

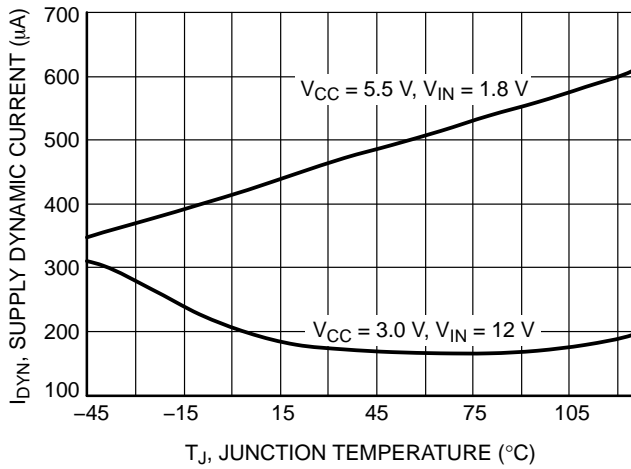


Figure 9. Supply Dynamic Current vs. Temperature

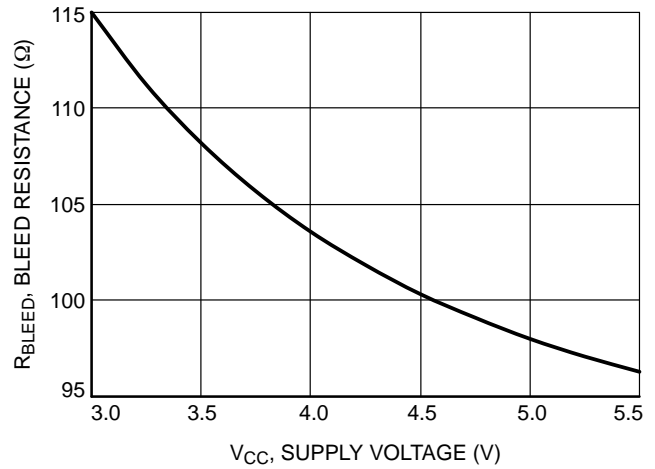


Figure 10. Bleed Resistance vs. Supply Voltage

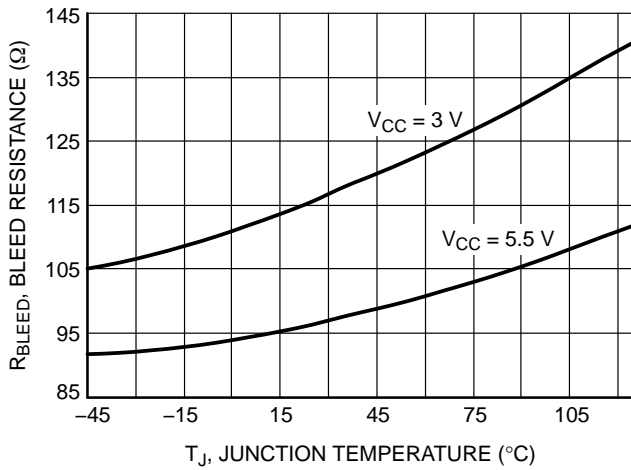


Figure 11. Bleed Resistance vs. Temperature

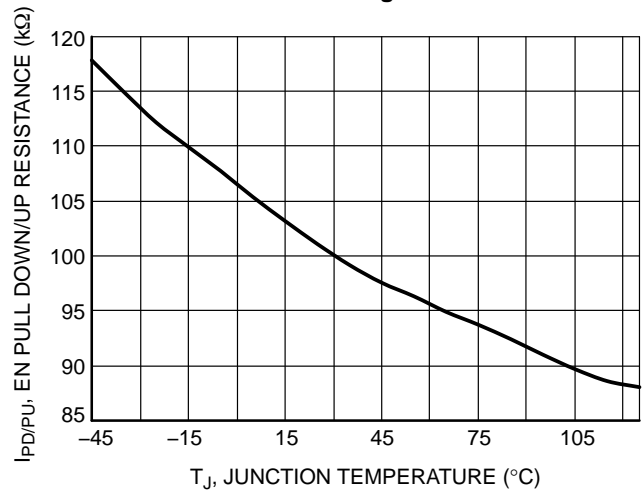


Figure 12. EN Pull Down/Up Resistance vs. Temperature

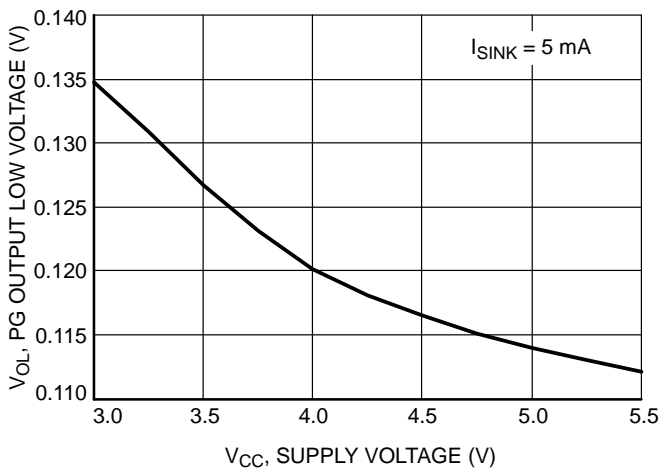


Figure 13. PG Output Low Voltage vs. Supply Voltage

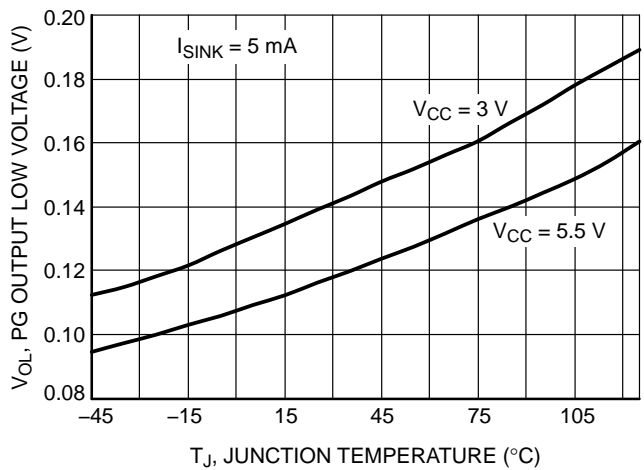


Figure 14. PG Output Low Voltage vs. Temperature

TYPICAL CHARACTERISTICS

($T_J = 25^\circ\text{C}$ unless otherwise specified)

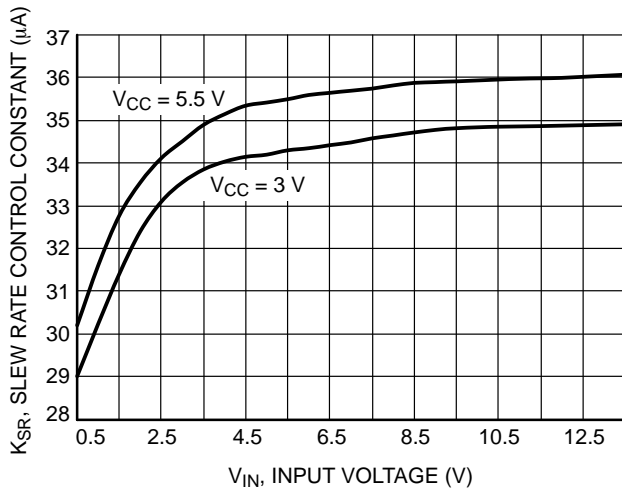


Figure 15. Slew Rate Control Constant vs. Input Voltage

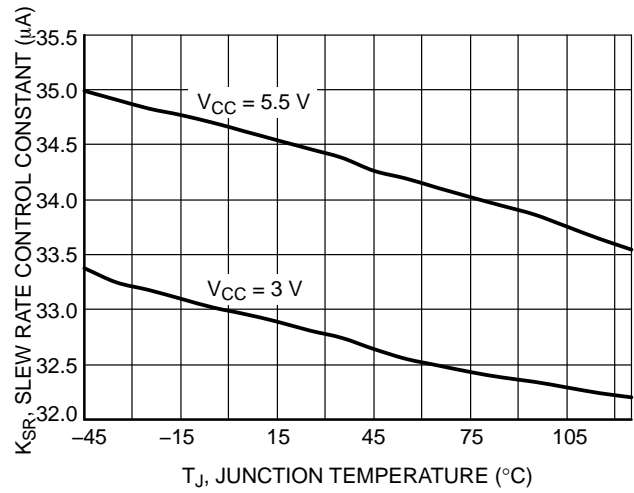


Figure 16. Slew Rate Control Constant vs. Temperature

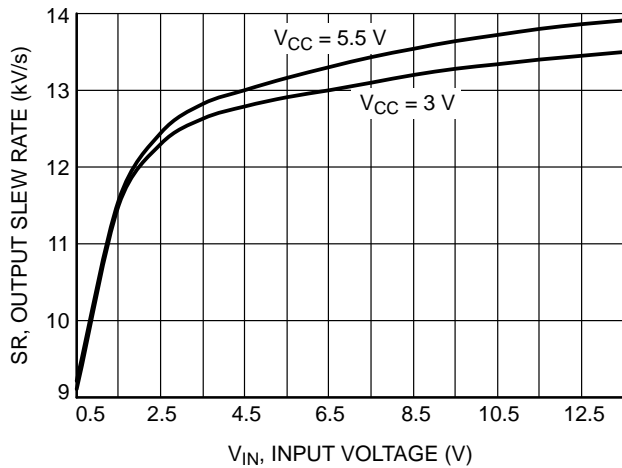


Figure 17. Output Slew Rate vs. Input Voltage

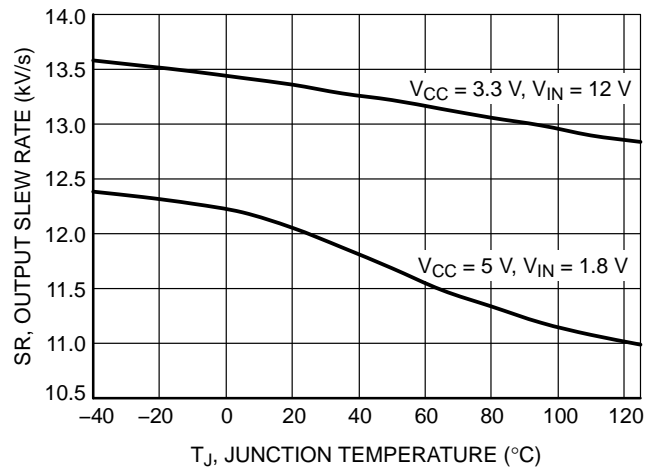


Figure 18. Output Slew Rate vs. Temperature

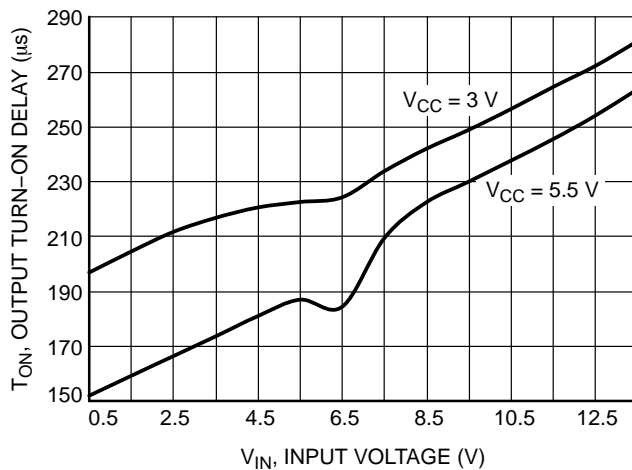


Figure 19. Output Turn-on Delay vs. Input Voltage

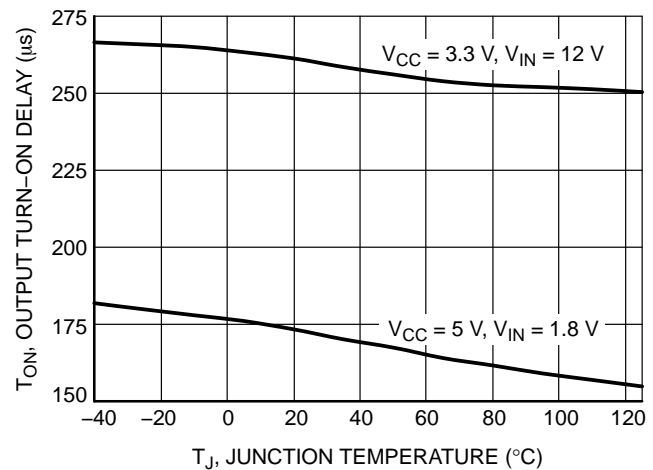


Figure 20. Output Turn-on Delay vs. Temperature

TYPICAL CHARACTERISTICS

($T_J = 25^{\circ}\text{C}$ unless otherwise specified)

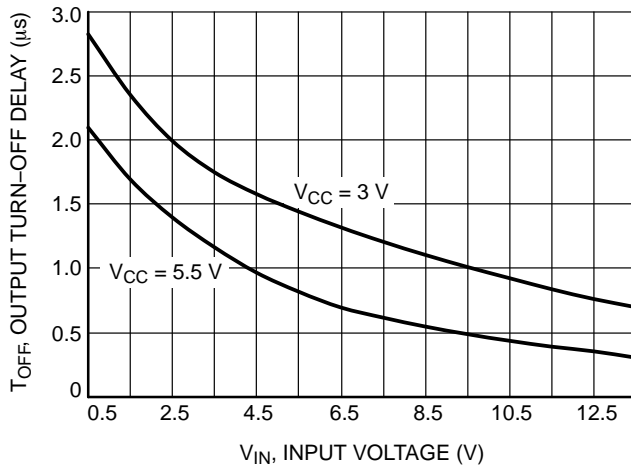


Figure 21. Output Turn-off Delay vs. Input Voltage

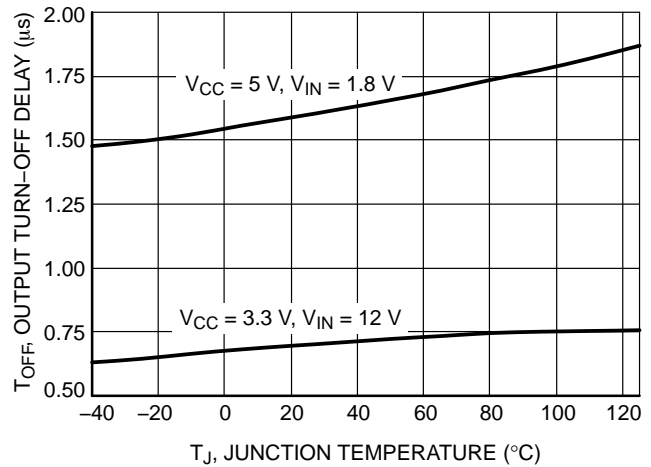


Figure 22. Output Turn-off Delay vs. Temperature

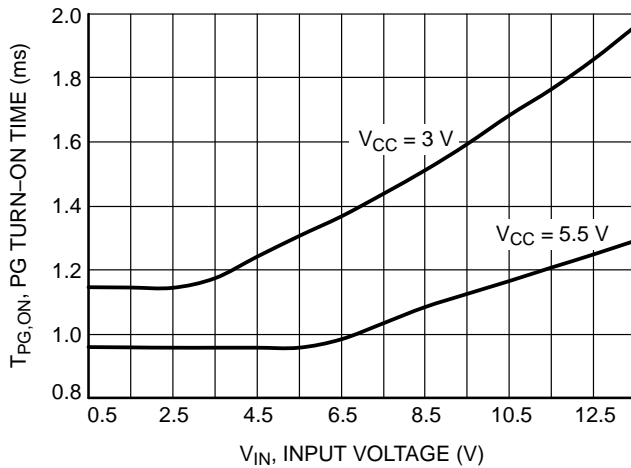


Figure 23. Power Good Turn-on Time vs. Input Voltage

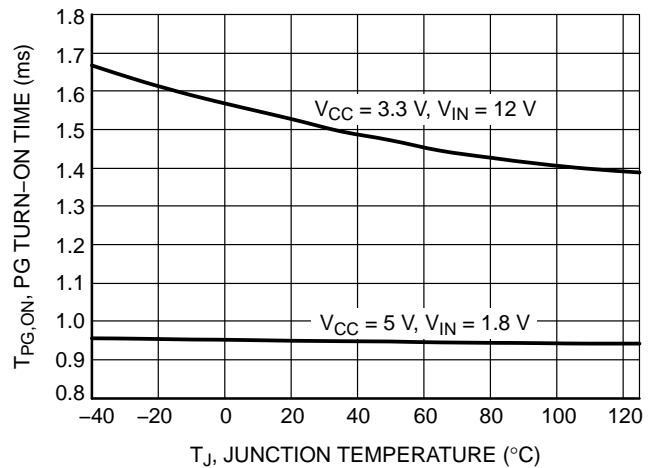


Figure 24. Power Good Turn-on Time vs. Temperature

TYPICAL CHARACTERISTICS

($T_J = 25^\circ\text{C}$ unless otherwise specified)

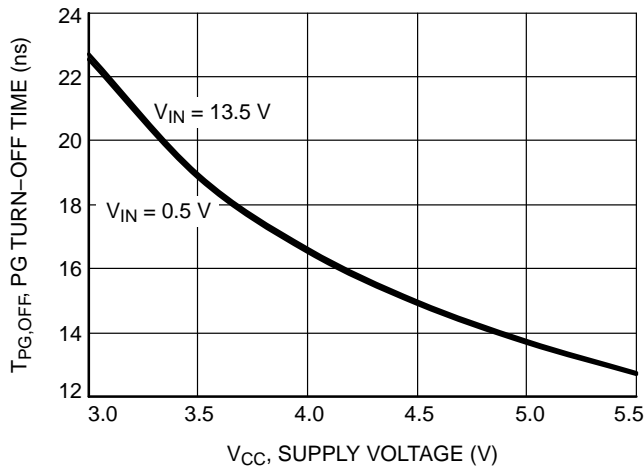


Figure 25. Power Good Turn-off Time vs. Supply Voltage

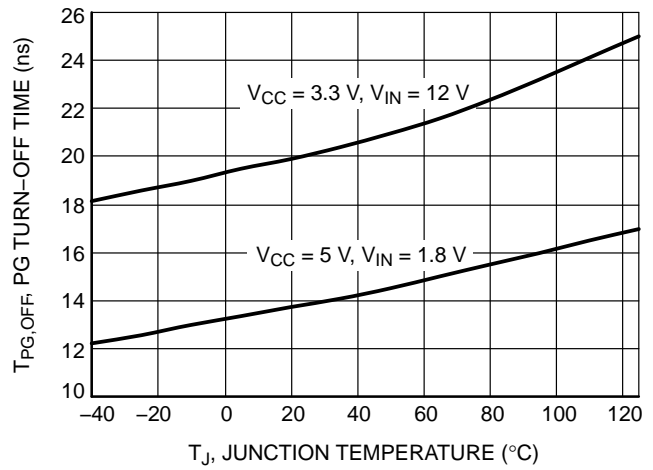


Figure 26. Power Good Turn-off Time vs. Temperature

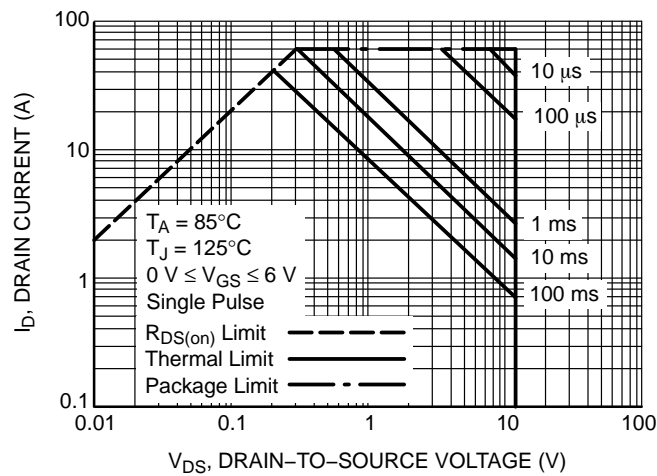


Figure 27. Maximum Rated Forward Biased Safe Operating Area

APPLICATIONS INFORMATION

Enable Control

The NCP45541 has two part numbers, NCP45541–H and NCP45541–L, that only differ in the polarity of the enable control.

The NCP45541–H device allows for enabling the MOSFET in an active–high configuration. When the V_{CC} supply pin has an adequate voltage applied and the EN pin is at a logic high level, the MOSFET will be enabled. Similarly, when the EN pin is at a logic low level, the MOSFET will be disabled. An internal pull down resistor to ground on the EN pin ensures that the MOSFET will be disabled when not being driven.

The NCP45541–L device allows for enabling the MOSFET in an active–low configuration. When the V_{CC} supply pin has an adequate voltage applied and the EN pin is at a logic low level, the MOSFET will be enabled. Similarly, when the EN pin is at a logic high level, the MOSFET will be disabled. An internal pull up resistor to V_{CC} on the EN pin ensures that the MOSFET will be disabled when not being driven.

Power Sequencing

The NCP45541 devices will function with any power sequence, but the output turn–on delay performance may vary from what is specified. To achieve the specified performance, there are two recommended power sequences:

1. $V_{CC} \rightarrow V_{IN} \rightarrow V_{EN}$
2. $V_{IN} \rightarrow V_{CC} \rightarrow V_{EN}$

V_{CC} must be at 2 V or higher when EN is asserted to ensure that the enable is latched properly for correct operation. If EN comes up before V_{CC} reaches 2 V, then the EN may not take effect.

Load Bleed (Quick Discharge)

The NCP45541 devices have an internal bleed resistor, R_{BLEED} , which is used to bleed the charge off of the load to ground after the MOSFET has been disabled. In series with the bleed resistor is a bleed switch that is enabled whenever the MOSFET is disabled. The MOSFET and the bleed switch are never concurrently active.

It is required that the BLEED pin be connected to V_{OUT} either directly (as shown in Figure 29) or through an external resistor, R_{EXT} (as shown in Figure 28). R_{EXT} should not exceed 100 M Ω and can be used to increase the total bleed resistance and decrease the load bleed rate.

Care must be taken to ensure that the power dissipated across R_{BLEED} is kept at a safe level. The maximum continuous power that can be dissipated across R_{BLEED} is 0.4 W. R_{EXT} can be used to decrease the amount of power dissipated across R_{BLEED} .

Power Good

The NCP45541 devices have a power good output (PG) that can be used to indicate when the gate of the MOSFET is fully charged. The PG pin is an active–high, open–drain output that requires an external pull up resistor, R_{PG} , greater

than or equal to 1 k Ω to an external voltage source, V_{TERM} , compatible with input levels of other devices connected to this pin (as shown in Figures 28 and 29).

The power good output can be used as the enable signal for other active–high devices in the system (as shown in Figure 30). This allows for guaranteed by design power sequencing and reduces the number of enable signals needed from the system controller. If the power good feature is not used in the application, the PG pin should be tied to GND.

Slew Rate Control

The NCP45541 devices are equipped with controlled output slew rate which provides soft start functionality. This limits the inrush current caused by capacitor charging and enables these devices to be used in hot swap applications.

The slew rate can be decreased with an external capacitor added between the SR pin and ground (as shown in Figures 28 and 29). With an external capacitor present, the slew rate can be determined by the following equation:

$$\text{Slew Rate} = \frac{K_{SR}}{C_{SR}} \text{ [V/s]} \quad (\text{eq. 1})$$

where K_{SR} is the specified slew rate control constant, found in Table 4, and C_{SR} is the slew rate control capacitor added between the SR pin and ground. The slew rate of the device will always be the lower of the default slew rate and the adjusted slew rate. Therefore, if the C_{SR} is not large enough to decrease the slew rate more than the specified default value, the slew rate of the device will be the default value. The SR pin can be left floating if the slew rate does not need to be decreased.

Capacitive Load

The peak in–rush current associated with the initial charging of the application load capacitance needs to stay below the specified I_{MAX} . CL (capacitive load) should be less than C_{max} as defined by the following equation:

$$C_{max} = \frac{I_{max}}{SR_{typ}} \quad (\text{eq. 2})$$

Where I_{MAX} is the maximum load current, and SR_{typ} is the typical default slew rate when no external load capacitor is added to the SR pin.

OFF to ON Transition Energy Dissipation

The energy dissipation due to load current traveling from V_{IN} to V_{OUT} is very low during steady state operation due to the low R_{ON} . When the EN signal is asserted high, the load switch transitions from an OFF state to an ON state. During this time, the resistance from V_{IN} to V_{OUT} transitions from high impedance to R_{ON} , and additional energy is dissipated in the device for a short period of time. The worst case energy dissipated during the OFF to ON transition can be approximated by the following equation:

$$E = 0.5 \cdot V_{IN} \cdot (I_{INRUSH} + 0.8 \cdot I_{LOAD}) \cdot dt \quad (\text{eq. 3})$$

Where V_{IN} is the voltage on the V_{IN} pin, I_{INRUSH} is the inrush current caused by capacitive loading on V_{OUT} , and dt is the time it takes V_{OUT} to rise from 0 V to V_{IN} . I_{INRUSH} can be calculated using the following equation:

$$I_{INRUSH} = \frac{dv}{dt} \cdot C_L \quad (\text{eq. 4})$$

Where dv/dt is the programmed slew rate, and C_L is the capacitive loading on V_{OUT} . To prevent thermal lockout or damage to the device, the energy dissipated during the OFF to ON transition should be limited to E_{TRANS} listed in operating ranges table.

ecoSWITCH LAYOUT GUIDELINES

Electrical Layout Considerations

Correct physical PCB layout is important for proper low noise accurate operation of all ecoSWITCH products.

Power Planes: The ecoSWITCH is optimized for extremely low R_{on} resistance, however, improper PCB layout can

substantially increase source to load series resistance by adding PCB board parasitic resistance. Solid connections to the V_{IN} and V_{OUT} pins of the ecoSWITCH to copper planes should be used to achieve low series resistance and good thermal dissipation. The ecoSWITCH requires ample heat dissipation for correct thermal lockout operation. The internal FET dissipates load condition dependent amounts of power in the milliseconds following the rising edge of enable, and providing good thermal conduction from the packaging to the board is critical. Direct coupling of V_{IN} to V_{OUT} should be avoided, as this will adversely affect slew rates. The figure below shows an example of correct power plane layout. The number and location of pins for specific ecoSWITCH products may vary. This demonstrates large planes for both V_{IN} and V_{OUT} , while avoiding capacitive coupling between the two planes.

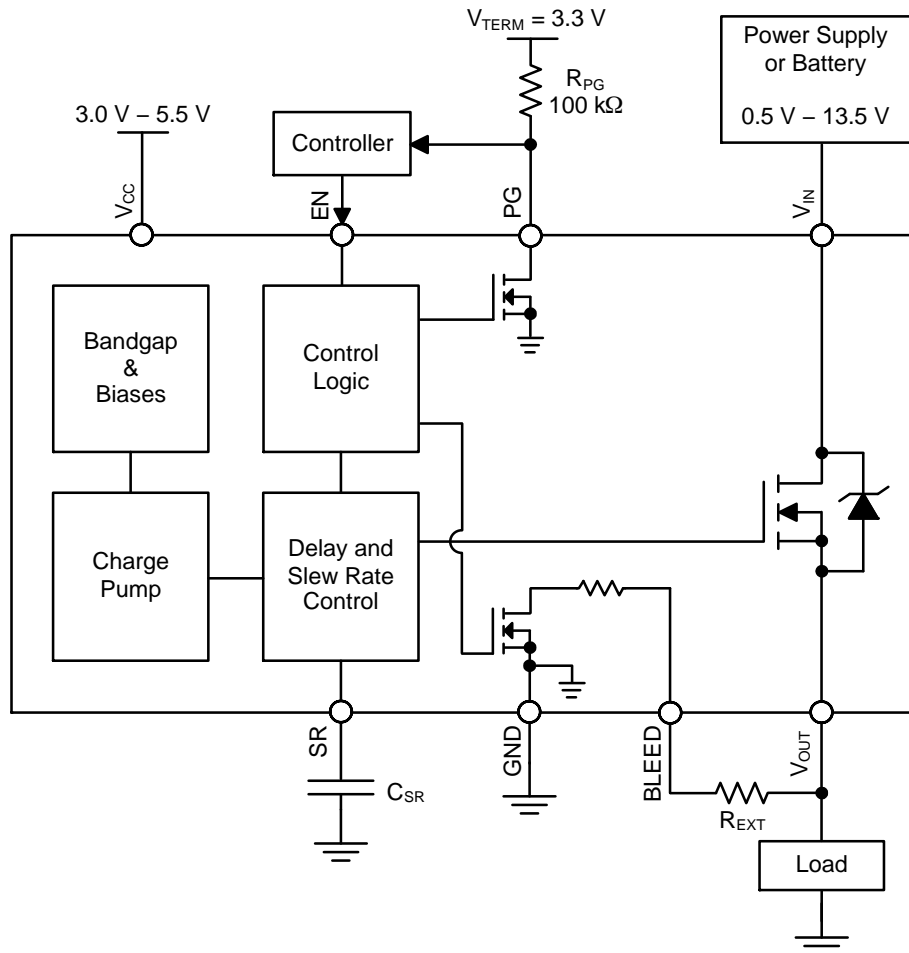


Figure 28. Typical Application Diagram – Load Switch

NCP45541

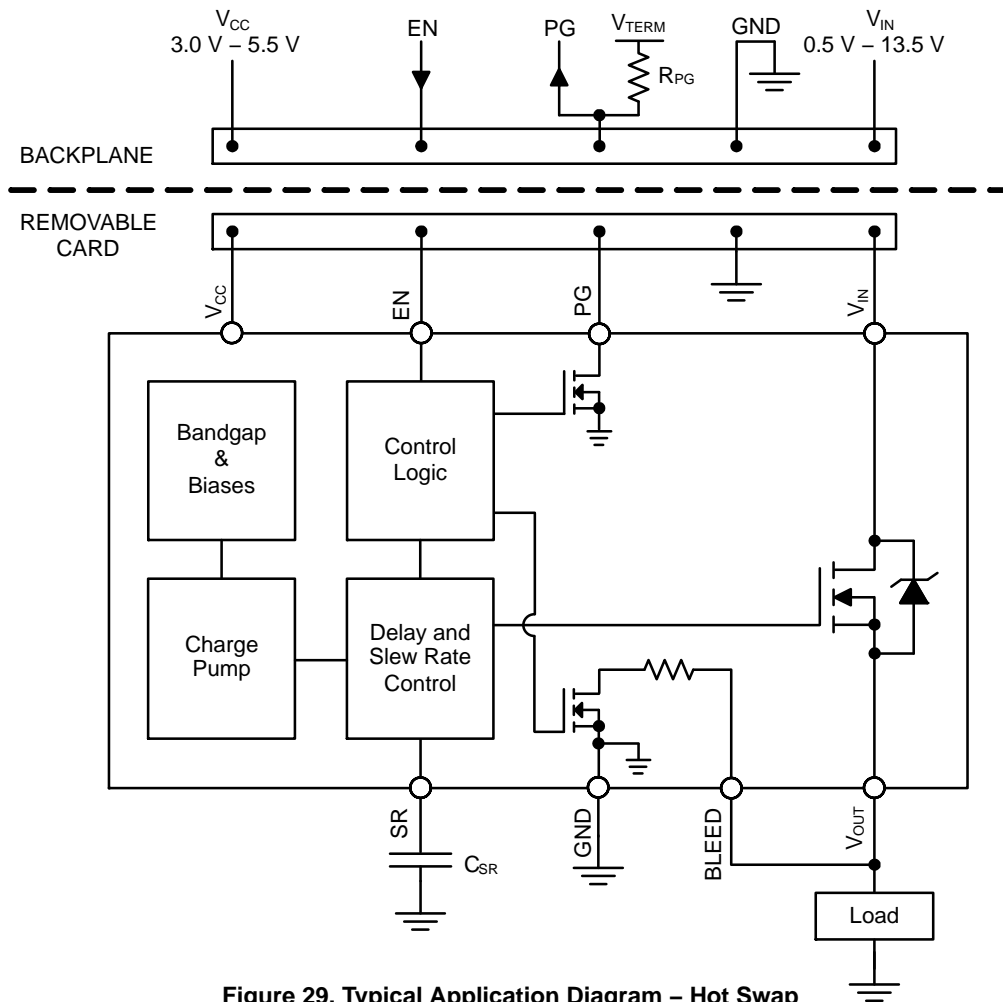


Figure 29. Typical Application Diagram – Hot Swap

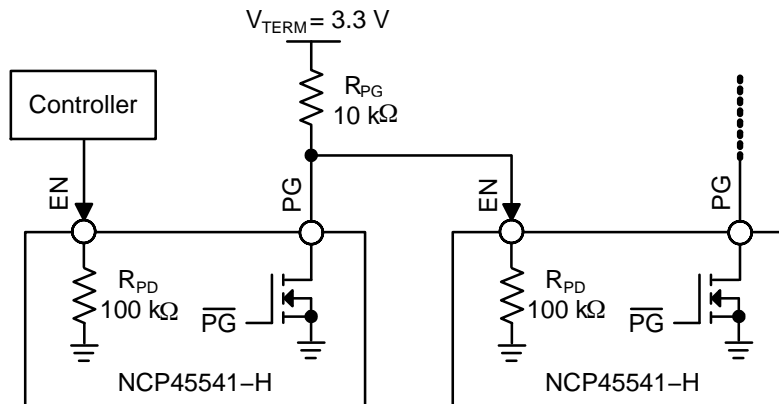


Figure 30. Simplified Application Diagram – Power Sequencing with PG Output

ORDERING INFORMATION

Device	EN Polarity	Package	Shipping†
NCP45541IMNTWG-H	Active-High	DFN12 (Pb-Free)	3000 / Tape & Reel
NCP45541IMNTWG-L	Active-Low		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

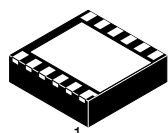
ecoSWITCH is a trademark of Semiconductor Components Industries, LLC (SCILLC).

MECHANICAL CASE OUTLINE

PACKAGE DIMENSIONS

ON Semiconductor®

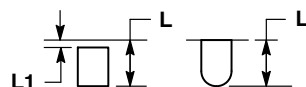
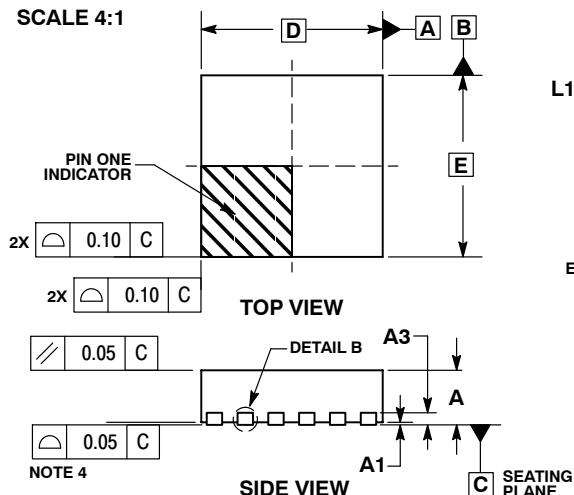
ON



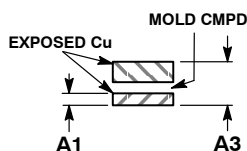
SCALE 4:1

DFN12 3x3, 0.5P
CASE 506CD
ISSUE A

DATE 18 FEB 2014



DETAIL A
ALTERNATE
CONSTRUCTIONS



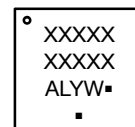
DETAIL B
ALTERNATE
CONSTRUCTION

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 MM FROM TERMINAL TIP.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

DIM	MILLIMETERS	
	MIN	MAX
A	0.80	1.00
A1	0.00	0.05
A3	0.20	REF
b	0.20	0.30
D	3.00	BSC
D2	2.60	2.80
E	3.00	BSC
E2	1.90	2.10
e	0.50	BSC
L	0.20	0.40
L1	---	0.15
L2	0.10	REF
K	0.15	MIN

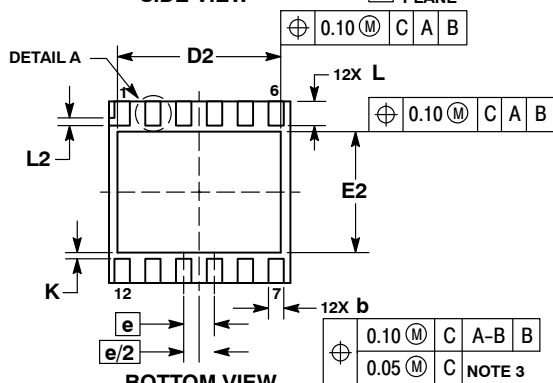
GENERIC MARKING DIAGRAM*



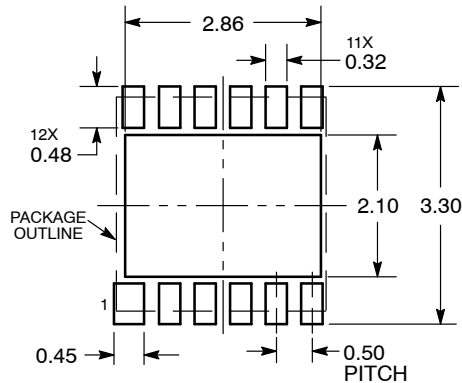
A = Assembly Location
L = Wafer Lot
Y = Year
W = Work Week
▪ = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "▪", may or may not be present.



RECOMMENDED SOLDERING FOOTPRINT*




DIMENSIONS: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

DOCUMENT NUMBER:	98AON67174E	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.
DESCRIPTION:	DFN12 3X3, 0.5P	PAGE 1 OF 1

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

ON Semiconductor and  are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Email Requests to: orderlit@onsemi.com

ON Semiconductor Website: www.onsemi.com

TECHNICAL SUPPORT

North American Technical Support:

Voice Mail: 1 800-282-9855 Toll Free USA/Canada

Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative

